Special Issue

Integrated Disaster Risk Management and Remote Sensing in the Age of Intelligence

Message from the Guest Editor

This Special Issue focuses on advances in remote sensing and GIS for hazards analysis, emergency studies, and disaster risk reduction in the age of intelligence. Governments around the world are investing in remote sensing for integrated all-hazard management in the age of artificial intelligence. This Special Issue will focus on technological transformations and ways in which advances in GIS and remote sensing can reduce disaster risk and increase integrated, all hazards, and comprehensive emergency management. This Special Issue also emphasizes that reducing disaster risk and investing in remote sensing technology can boost overall economic productivity, save lives, minimize damage to critical infrastructure and revitalize the economy. Prof. Jason K. Levy

Guest Editor

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Message from the Editor-in-Chief

Sensors is a leading journal devoted to fast publication of the latest achievements of technological

developments and scientific research in the huge area of physical, chemical and biochemical sensors, including remote sensing and sensor networks. Both experimental and theoretical papers are published, including all aspects of sensor design, technology, proof of concept and application. Sensors organizes Special Issues devoted to specific sensing areas and applications each year.

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